

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination HASEGAWA ET AL.	
			Examiner Peter J. Macchiarolo	Art Unit 2879	Page 1 of 1

**U.S. PATENT DOCUMENTS**

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*	C	US-6,171,438	01-2001	Masuda et al.	156/345.27
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Computer translation of Applicant cited Hidaka JP PUB 2001-110321
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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